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- 4 nanotubes considering tip-charge concentration
- 5 and intermolecular forces
- 6 Giovanni Bianchi · Enrico Radi

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9	Abstract	Two-side a	ccura	te analy	tical estim	ates of
0	the pull-in	parameters	of a	carbon	nanotube	switch

- clamped at one end under electrostatic actuation are
- 12 provided by considering the proper expressions of the
- 13 electrostatic force and van der Waals interactions for a
- carbon nanotube, as well as the contribution of the charge concentration at the free end. According to the
- 6 Euler–Bernoulli beam theory, the problem is governed
- by a fourth-order nonlinear boundary value problem.
- 18 Two-side estimates on the centreline deflection are
- derived. Then, very accurate lower and upper bounds
- 20 to the pull-in voltage and deflection are obtained as
- 20 to the pull-in voltage and deflection are obtained as 2 AQ2 function of the geometrical and material parameters.
- The analytical predictions are found to agree remark-
- 23 ably well with the numerical results provided by the
- 24 shooting method, thus validating the proposed
- 25 approach. Finally, a simple closed-form relation is
- 26 proposed for the minimum feasible gap and maximum
- 27 realizable length for a freestanding CNT cantilever.
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Keywords	Carbon nanotube · Pull-in voltage ·	28
NEMS · Nar	nocantilever · van der Waals interactions ·	29
Charge cond	eentration	30

#### 1 Introduction

Carbon nanotubes (CNTs) display a number of smart electronic and mechanical properties that are currently exploited in a wide variety of industrial applications, such as sensors, nanoactuators, memory devices, switches, high frequency nanoresonators and nanotweezers [1-3]. Due to their tiny size, CNTs display ultra-low mass and very high resonance frequency. Moreover, they undergo purely elastic behaviour, they are able to carry huge electrical currents and to sustain high current densities. These attractive properties, in conjunction with the significant progress recently made in the fabrication of carbon nanostructures, allow CNTs to become essential components in the production of enhanced nano-electro-mechanical systems (NEMS) [1]. As a consequence, a considerable amount of research interest has been dedicated to the accurate modelling of the structural and electric behavior of CNTs in the last few years.

A typical CNT switch consists in a moveable nanowire suspended over a fixed conductive ground plane, usually made of graphite. By applying DC voltage difference between the components, the CNT





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deflects toward the ground electrode until at the pull-in voltage it sticks on the ground plane, thus shortening the electric circuit. The atomic interactions at the nano-scale separations, modelled by the van der Waals force, substantially affects the pull-in instability of NEMS. Both the electrostatic and van der Waals forces depend on the CNT deflection non-linearly. This occurrence makes every attempt to describe their response in closed form a very difficult task. Specifically, no exact solution can be found for the nonlinear ordinary differential equation (ODE) governing the CNT deflection under electrostatic actuation. As a consequence, a variety of numerical and approximated approaches has been proposed in the technical literature, ranging from the reduction to 1D lumped models, based on the assumption of appropriate shape functions for the CNT deflection, to the use of powerful numerical techniques to generate reducedorder models, such as the Differential Quadrature Method, the Galerkin Discretization Method or the Finite Element Method [4–11]. However, these approximated methods may provide significant error percentages as the CNT deflection increases and gets closer to the pull-in limit. Moreover, they predict arbitrary estimates of the effective pull-in parameters, whereas an effective approach should provide accurate lower and upper bounds that can be exploited for ensuring the safe operation of the device. Alternatively, molecular dynamics approaches have been adopted to study CNTs pull-in behavior [12]. However, these methods are very time-consuming and can not be easily employed for large structures.

As remarked by Ke et al. [13, 14], electric charges tend to concentrate at the ends of a linear conductor and thus for proper modeling of the pull-in instability phenomenon the effect of the concentrated load due to charge concentration at the end of a CNT cantilever is expected to provide a significant contribution on the deflection of CNT and consequently on the pull-in instability. Therefore, it must be necessarily considered for the accurate evaluation of the pull-in voltage. In particular, Ke et al. [13] showed that the pull-in voltage decreases by about 14% due to the effect of the tip-charge concentration. They also provided an approximate relation for the pull-in voltage that account for the effects of tip-charge concentration and finite kinematics. They found that the finite kinematic effect is negligible for a CNT-based cantilever switch, but the effect of charge concentration is quite significant. Ke [15] also presented a detailed review of the recent advances in the electro-mechanical modeling and characterization of CNT cantilevers and their applications.

The development of analytical models that can predict the pull-in response of the device becomes extremely relevant for identifying the most efficient geometries and materials required for meeting the requests of ultralow power consumption, strength and durability. Despite the amount of numerical and approximated investigations, analytical models and closed form expressions for assessing the occurring of CNT pull-in instability still appears to be limited. An accurate determination of the stable actuating range and the pull-in instability threshold is a crucial issues for the design of reliable and optimized CNT-based NEMS. In two previous works, Radi et al. [16, 17] provided an analytical methodology for assessing accurate lower and upper bounds to the pull-in parameters of an electro-statically actuated micro- or nano-cantilever, by taking the contributions of flexible support and compressive axial load into consideration. Both contributions are found to reduce the pull-in voltage and to increase the critical gap spacing for a freestanding nano-cantilever, namely in the absence of electrical actuation. The investigations [16, 17] have focused on the pull-in instability in micro- and nanobeams with rectangular cross-section only. Moreover, the contribution of the charge concentrated at the nanocantilever tip has been neglected in these works.

In the present work, attention is paid to investigate the pull-in phenomenon in CNT with circular crosssection rolled up by graphene sheets, by considering the proper expressions of the electrostatic force as well as the significant effect induced by the tip-charge concentration [13, 14, 18, 19]. The van der Waals force acting on the CNT has been derived in [4] starting from the Lennard-Jones potential (see also [8, 20–22]). The finite kinematic effect has been neglected here, Ke et al. [13, 14] found indeed that for a clamped CNT it becomes significant only for very slender CNTs and large gap spacing. Indeed, the pullin instability generally occurs as the CNT tip deflections attains about  $1/3 \div 1/2$  of the gap spacing, which is much smaller than the CNT length. Within this range, the CNT can be reasonably supposed to experience small deformations and small displacement. Therefore, reference is made here to the classic Euler-Bernoulli (EB) beam theory, which is valid for



actuators [23]. The main advantage of the present approach with respect to other ones proposed in literature consists in providing accurate analytical bounds from above and below for the pull-in voltage and pull-in deflection, thus avoiding the numerical integration of the nonlinear fourth-order ODE derived from the EB beam theory. Moreover, the present work extends previous investigations on nanobeams with rectangular cross section [16, 17], which are not specifically addressed to CNTs and do not take the contribution of the concentrated-tip charge into account.

most of the CNT applications as switches and

By introducing few non-dimensional parameters, the nonlinear ODE for the CNT centreline deflection and the corresponding boundary conditions are presented in Sect. 2. Moreover, an equivalent integral equation formulation is derived therein. The nonlinear response is due to the electrostatic force and van der Waals interactions, which depends on the beam deflection nonlinearly, whereas the CNT is modelled by using a linear elastic EB beam. The solution of the boundary value problem is then proved to be positive, increasing and convex. Upper and lower estimates for the CNT deflection are obtained in Sect. 3. Accurate two-side analytical bounds to the pull-in parameters are derived in Sect. 4 by exploiting the estimates obtained in Sect. 3. The accuracy of the proposed bounds are then validated in Sect. 5 by comparing the analytical estimates and the numerical results provided by the shooting method. A remarkable agreement is observed therein. On the basis of the obtained results, an approximated closed-form expression is finally proposed for permissible gap spacing and CNT

length under the influence of intermolecular attractions.

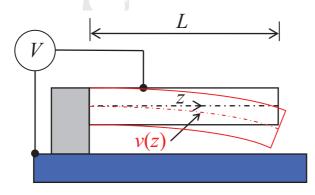
The approach here proposed refers to a single-walled CNT. However, it can be easily generalized to multi-walled CNTs, e.g. by considering the expressions of the electrostatic and van der Waals forces provided in [24], as well as to other kinds of interactions, such as capillary and electrochemical forces [25, 26].

#### 2 Mathematical modeling

A schematic view of a CNT-based cantilever switch is shown in Fig. 1. A movable single-walled or multiwalled CNT is placed above a fixed ground plane and subject to van der Waals interactions and attractive electrostatic force due to applied voltage. The nanotube length and the cross section mean radius are denoted with L and R, respectively. The gap spacing between the nanotube and the ground plane is denoted by H. The deflection v(z) of the CNT centreline is described by the following non-linear fourth-order ODE written in terms of the nondimensional variables u = v/H and x = z/L for  $0 \le x \le 1$  and  $0 \le u \le 1$ 

$$u^{\text{IV}}(x) = f(u(x)), \text{ for } x \in [0, 1],$$
 (1)

where the prime denotes differentiation with respect to the function argument. The CNT actuation is modelled by considering both contributions of electrostatic force and van der Waals interactions, namely



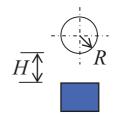


Fig. 1 A CNT based cantilever switch under electrostatic loading

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$$f(u) = \beta f_e(u) + \gamma F_c(u), \tag{2}$$

- 214 where the normalized electrostatic and van der Waals
- 215 forces for the cylindrical geometry are given by
- 216 [4, 8, 13, 14, 18–22, 27, 28]

$$f_e(u) = \frac{1}{\sqrt{(1-u)(1-u+2/k)[\cosh^{-1}(1+k-ku)]^2}},$$

$$f_c(u) = \frac{8k^4(1-u)^4 + 32k^3(1-u)^3 + 72k^2(1-u)^2 + 80k(1-u) + 35}{k^{10}[(1-u)(1-u+2/k)]^{9/2}},$$
(3)

- where k = H/R is a geometric ratio and the nondimensional parameters  $\beta$  and  $\gamma$  are proportional to the
- 220 magnitude of the electrostatic force and van der Waals
- 221 interactions, respectively, namely

$$\beta = \frac{\pi \varepsilon_0 V^2 L^4}{H^2 F I}, \quad \gamma = \frac{C_6 \sigma^2 \pi^2 L^4}{2R^5 F I} \tag{4}$$

- 223 where  $\varepsilon_0 = 8.854 \times 10^{-12} \text{ C}^2 \text{ N}^{-1} \text{ m}^{-2}$  is the per-
- 224 mittivity of vacuum, V is the electric voltage applied to
- 225 the electrodes,  $C_6 = 15.2 \text{ Ev Å}^6$  is a constant charac-
- 226 terizing the interaction between carbon–carbon atoms,
- 227  $\sigma = 38 \text{ nm}^{-2}$  is the graphene surface density,  $I \approx \pi t$

rotation at the clamped end (x = 0), vanishing of the bending moment and assigned shearing force at the free end (x = 1), namely

$$u(0) = 0, \quad u'(0) = 0, \quad u''(1) = 0,$$
  
 $u'''(1) = -\beta q(\delta),$  (5)

where  $\delta = u(1)$  is the tip displacement and

$$q(\delta) = \frac{0.85\rho(1+k)^{2/3}}{\sqrt{(1-\delta)(1-\delta+2/k)}\left[\cosh^{-1}(1+k-k\delta)\right]^2},$$
(6)

is the normalized shearing force due to the electrostatic attraction of the charge concentrated at the CNT tip [13, 14, 27], being  $\rho = R/L$  the inverse of the CNT slenderness.

By taking the derivative of Eq. (2) with respect to *u*, 254 one obtains 255

$$f'(u) = \beta f'_e(u) + \gamma F'_c(u), \tag{7}$$

$$f'_{e}(u) = \frac{1}{(1-u)(1-u+2/k)[\cosh^{-1}(1+k-ku)]^{2}} \left[ \frac{2}{\cosh^{-1}(1+k-ku)} + \frac{1-u+1/k}{\sqrt{(1-u)(1-u+2/k)}} \right],$$

$$f'_{c}(u) = 5 \frac{8k^{5}(1-u)^{5} + 40k^{4}(1-u)^{4} + 120k^{3}(1-u)^{3} + 200k^{2}(1-u)^{2} + 175k(1-u) + 63}{k^{11}[(1-u)(1-u+2/k)]^{11/2}}.$$
(8)

- 228  $R^3$  is the moment of inertia of the CNT cross-section,
- 229 where t is the CNT wall thickness, and E is the
- 230 Young's modulus of the graphene. A number of
- 231 studies based on experimental tests and atomistic
- 232 simulations found that the Young's modulus of the
- graphene varies from 0.5 to 5.5 TPa and the single
- wall thickness ranges between 0.7 and 3.4 Å, see the
- summary of results given in [29]. The mean values suggested in [29] are t = 1.34 Å and E = 2.52 TPa.
- The van der Waals force per unit length  $(3)_2$  has been derived in [4] by taking the derivative with
- 239 respect to the deflection of the van der Waals energy
- 240 determined by double volume integral of the Lennard–
- Jones potential.The boundary conditions for the can
- The boundary conditions for the cantilever EB beam then require vanishing of displacement and

Note that the functions f(u) and f'(u) defined in (2) and (7) are positive and monotonically increasing for  $0 \le u \le 1$  and k > 0, namely 261

$$f(u) \ge f(0) \ge 0,$$
  $f'(u) \ge f'(0) \ge 0,$  (9)

$$f(0) = \frac{\beta}{\sqrt{(1+2/k)}[\cosh^{-1}(1+k)]^2} + \gamma \frac{8k^4 + 32k^3 + 72k^2 + 80k + 35}{k^{10}(1+2/k)^{9/2}},$$
 (10)

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$$f'(0) = \beta \frac{2\sqrt{k(2+k)} + (1+k)\cosh^{-1}(1+k)}{(2+k)\sqrt{(1+2/k)}\left[\cosh^{-1}(1+k)\right]^{3}} + 5\gamma \frac{8k^{5} + 40k^{4} + 120k^{3} + 200k^{2} + 175k + 63}{k^{11}(1+2/k)^{11/2}}.$$
(11)

- 267 2.1 Nonlinear integral equation for u(x)
- 268 In this section, the governing ODE (1) is integrated
- 269 four times by using the boundary conditions (5), in
- order to obtain preliminary estimates about the solution u(x) and its derivatives up to the third order.
- solution u(x) and its derivatives up to the third order
- 272 Moreover, a nonlinear integral equation for the
- 273 deflection u is obtained, which will be used later for
- achieving accurate bounds for the pull-in parameters.
   A first integration of the governing ODE (1) between x
- and 1 by using the boundary condition (5)<sub>4</sub> yields

$$u'''(x) = -\int_{x}^{1} f(u(t))dt - \beta q(\delta). \tag{12}$$

- 278 Integration of Eq. (12) between x and 1, by using the
- boundary condition (5)<sub>3</sub> and integration by parts, then
- 280 yields

$$u''(x) = \int_{x}^{1} (t - x)f(u(t))dt + (1 - x)\beta q(\delta).$$
 (13)

- Integration of Eq. (13) between 0 and x, by using the
- boundary condition  $(5)_2$  and integration by parts, then
- 284 yields

$$u'(x) = \frac{1}{2} \left\{ x \int_{x}^{1} (2t - x) f(u(t)) dt + \int_{0}^{x} t^{2} f(u(t)) dt + \beta q(\delta)(2 - x) x \right\}.$$
(14)

- 286 Finally, integration of Eq. (14) between 0 and x by
- using the boundary condition  $(5)_1$  and integration by
- 288 parts gives the following nonlinear integral equation
- 289 for u(x)

$$u(x) = \frac{1}{6} \left\{ x^2 \int_{x}^{1} (3t - x)f(u(t))dt + \int_{0}^{x} (3x - t)t^2 f(u(t))dt + \beta q(\delta)(3 - x)x^2 \right\}.$$
(15)

The normalized deflection of the cantilever tip,  $\delta = u(1)$ , then must satisfy the following condition derived from Eq. (15) for x = 1 293

$$\delta = \frac{1}{6} \int_{0}^{1} (3 - t)t^{2} f(u(t)) dt + \frac{1}{3} \beta q(\delta).$$
 (16)

Considering that  $f(u) \ge 0$  and  $q(\delta) \ge 0$ , from Eqs. (1), (12)–(15) the following conditions then hold true for  $x \in [0, 1]$ : 295

$$u(x) \ge \frac{x^2}{6} (3 - x) \beta q(\delta) \ge 0,$$

$$u'(x) \ge \left(x - \frac{x^2}{2}\right) \beta q(\delta) \ge 0,$$

$$u''(x) \ge (1 - x) \beta q(\delta) \ge 0,$$

$$u'''(x) < -\beta q(\delta).$$

$$(17)$$

Therefore, the function u(x) is positive, increasing and convex for  $x \in (0, 1)$ .

#### **3 Two-side estimates for the deflection** 301

In order to define upper and lower bounds to the pull-in parameters, two-side estimates are first derived for the deflection u(x). 303

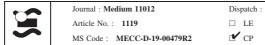
3.1 Upper bounds to the deflection u(x) 305

Let u(x) denotes the solution to the BVP (1) and (5), 306 then it can be proved that  $u(x) \le u_U(x)$  for  $x \in [0, 1]$ , 307 where 308

 $u_U(x) = \delta b_1(x) + \beta q(\delta) [b_2(x) + f'(0)b_3(x)],$  (18) and

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$$b_1(x) = \frac{1}{3}x^2(x^2 - 4x + 6) \ge 0,$$
  

$$b_2(x) = \frac{1}{18}x^2(1 - x)(2x - 3) \ge 0,$$
(19)

312 
$$b_3(x) = \frac{1}{5040}x^2(1-x)\left(x^4 - 6x^3 - 6x^2 + 38x - 33\right) \le 0.$$
 (20)

314 Indeed, let us define the function

$$h(x) = \delta b_1(x) + \beta q(\delta) \left[ b_2(x) + f'(0)b_3(x) \right] - u(x),$$
(21)

316 then the derivatives of h(x) up to the fourth order 317 become

Therefore, the function h(x) satisfies all the requirements for the application of Lemma A reported in the "Appendix", and thus  $h(x) \ge 0$  for  $x \in [0, 1]$ , so that, by using the definition (21), the upper bound (18) for the CNT deflection holds true.

The term  $\delta b_1(x)$  appearing in (18) coincides with the quartic polynomial used for approximating nanobeam deflection in [30]. Moreover, from conditions (18), by using (9)<sub>2</sub> and (20) it follows that

$$u(x) \le \delta b_1(x) + \beta q(\delta)b_2(x), \quad \text{for} \quad x \in [0, 1],$$

$$(25)$$

Obviously, the upper bound (25) is less accurate than (18), but it depends linearly on the parameter  $\beta$ . 338

$$h'(x) = 4\delta\left(\frac{x^3}{3} - x^2 + x\right) - \frac{\beta}{18}q(\delta)\left[\frac{f'(0)}{280}\left(7x^6 - 42x^5 + 176x^3 - 213x^2 + 66x\right) + 8x^3 - 15x^2 + 6x\right] - u'(x),$$

$$h''(x) = 4\delta(1 - x)^2 + \frac{\beta}{3}q(\delta)\left(1 - x\right)\left[\frac{f'(0)}{280}\left(7x^4 - 28x^3 - 28x^2 + 60x - 11\right) + 4x - 1\right] - u''(x),$$

$$h'''(x) = -8\delta(1 - x) - \frac{\beta}{3}q(\delta)\left[\frac{f'(0)}{280}\left(35x^4 - 140x^3 + 176x - 71\right) + 8x - 5\right] - u'''(x),$$

$$h^{IV}(x) = 8\delta - \frac{\beta}{3}q(\delta)\left[\frac{f'(0)}{70}\left(35x^3 - 105x^2 + 44\right) + 8\right] - u^{IV}(x).$$

$$(22)$$

318

Moreover, by taking the derivative of  $h^{IV}(x)$ , using

320 Eq. (1), one has

$$h^{V}(x) = \beta q(\delta)f'(0)\left(x - \frac{1}{2}x^{3}\right) - f'(u)u'(x) \le 0,$$
(23)

- 322 where the last inequality follows from  $(9)_2$  and  $(17)_2$ ,
- 323 thus implying that the function h'''(x) is concave.
- 324 Then, the following conditions are met by function
- 325 h(x) and its derivatives

$$h(0) = 0, \quad h(1) = 0, \quad h'(0) = 0, \quad h''(1) = 0,$$
  
 $h'''(1) = 0, \quad h^{V}(x) \le 0.$  (24)

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Therefore, two slightly different procedures for deriving lower bound to the pull-in parameters will be developed in Sect. 4.1 starting from the bounds (18) and (25), respectively.

3.2 Lower bounds to the deflection u(x) 343

Let u(x) denote the solution to the BVP (1) and (5), then the lower bound  $u(x) \ge u_L(x)$  holds true for  $x \in [0, 1]$ , where 345

$$u_L(x) = \delta a_1(x) + f(0)a_2(x) \tag{26}$$

and 348

$$a_1(x) = \frac{1}{2} (3x^2 - x^3) \ge 0,$$
  

$$a_2(x) = \frac{1}{48} (3x^2 - 5x^3 + 2x^4) \ge 0.$$
(27)

Let us indeed define the following function 350

$$g(x) = u(x) - \frac{\delta}{2} (3x^2 - x^3)$$
$$-\frac{f(0)}{48} (3x^2 - 5x^3 + 2x^4), \tag{28}$$

352 then the derivatives of g(x) write

$$\begin{split} g'(x) &= u'(x) - \frac{3}{2}\delta(2x - x^2) - \frac{f(0)}{48}\left(6x - 15x^2 + 8x^3\right), \\ g''(x) &= u''(x) - 3\delta(1 - x) - \frac{f(0)}{8}\left(1 - 5x + 4x^2\right), \\ g'''(x) &= u'''(x) + 3\delta + (5 - 8x), \\ g^{\text{IV}}(x) &= u^{\text{IV}}(x) - f(0) \ge 0, \end{split}$$

(29)

- where the latter inequality follows from Eqs. (1) and 354
- 355  $(9)_1$ . Therefore, the function g(x) satisfies the follow-
- 356 ing boundary conditions

$$g(0) = 0$$
,  $g(1) = 0$ ,  $g'(0) = 0$ ,  $g''(1) = 0$ . (30)

- Therefore, the function g(x) satisfies all the require-358
- ments for the application of Lemma B proved in 359
- "Appendix". It follows that  $g(x) \ge 0$  for  $x \in [0, 1]$ , so 360
- 361 that, by using the definition (28), the lower bound (26)
- 362 for the CNT deflection holds true.

#### 363 4 Bounds to the pull-in parameters

- 364 By introducing the estimates (18), (25) and (26) on the
- 365 deflection u(x) in relation (16), the following lower
- 366 and upper bounds to the pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$
- 367 can be derived analytically.
- 4.1 Accurate lower bounds to the pull-in 368
- 369 parameters
- 370 By using  $(9)_2$  and the upper bound to the CNT
- deflection (18) one has  $f(u) \le f(u_U)$ , then from (16) it 371
- 372

$$\delta \le F(\delta, \beta) + \frac{\beta}{3}q(\delta), \tag{31}$$

374 where the function

$$F(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) f(u_{U}(t)) dt$$
 (32)

can be calculated numerically.

Condition (31) defines a lower bound to the relation between the electrostatic loading parameter  $\beta$  and the normalized pull-in deflection  $\delta$ . The maximum value of the parameter  $\beta$  and the corresponding tip deflection  $\delta$  obtained from relation (31) by using the stationary condition

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$$\frac{\partial \beta}{\partial \delta} = 0, \tag{33}$$

then define the lower bounds of the pull-in parameters  $\beta_L$  and  $\delta_L$ , such that  $\beta_{PI} \geq \beta_L$  and  $\delta_{PI} \geq \delta_L$ , which are given by the following two conditions

$$F(\delta_L, \beta_L) + \frac{\beta_L}{3} q(\delta_L) = \delta_L,$$
  

$$\Phi(\delta_L, \beta_L) + \frac{\beta_L}{3} q'(\delta_L) = 1,$$
(34)

where the function 388

$$\Phi(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) \{b_{1}(t) + \beta q'(\delta) [b_{2}(t) + f'(0)b_{3}(t)]\} f'(u_{U}(t)) dt$$
(35)

can be calculated numerically and is given by the derivative with respect to  $\delta$  of the function  $F(\delta, \beta)$ defined in (32), performed by considering the maximization condition (33) and the definition (18) of  $u_U$ .

4.1.1 Lower bounds to the pull-in parameters 394

By using the estimate (25) and the monotony condi-395 tions  $f_e'(u) \ge 0$  and  $f_c'(u) \ge 0$ , from (16) it follows 396

$$\delta \le \beta f_e(\delta) + \gamma F_c(\delta) + \frac{\beta}{3} q(\delta), \tag{36}$$

where the functions 398

$$F_e(\delta) = \frac{1}{6} \int_0^1 t^2 (3 - t) f_e(\delta b_1(t) - \beta q(\delta) b_2(t)) dt,$$
(37)

400  $F_c(\delta) = \frac{1}{6} \int t^2 (3-t) f_c(\delta b_1(t) - \beta q(\delta) b_2(t)) dt,$ (38)

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402 can be calculated numerically.

Condition (36) defines a lower bound to the relation between the electrostatic loading parameter  $\beta$  and the normalized pull-in deflection  $\delta$ . In this case, inequality (36) can be easily solved for the parameter  $\beta$ . The maximum value of the parameter  $\beta$  and the corresponding tip deflection  $\delta$  obtained from relation (36) by using the stationary condition (33) then provides the lower bounds of the pull-in parameters  $\beta_L$  and  $\delta_L$ . Namely, the latter values are given by the conditions

$$\beta_L F_e(\delta_L) + \gamma F_c(\delta_L) + \frac{\beta_L}{3} q(\delta_L) = \delta_L,$$
  

$$\beta_L F'_e(\delta_L) + \gamma F'_c(\delta_L) + \frac{\beta_L}{3} q'(\delta_L) = 1,$$
(39)

where the apex denotes the derivative with respect to the function argument within the brackets, namely

$$F'_{e}(\delta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) [b_{1}(t) - \beta q'(\delta) b_{2}(t)] f'_{e}(\delta b_{1}(t) - \beta q(\delta) b_{2}(t)) dt,$$
(40)

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$$F'_{c}(\delta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) [b_{1}(t) - \beta q'(\delta) b_{2}(t)] f'_{c}(\delta b_{1}(t) - \beta q(\delta) b_{2}(t)) dt.$$

- The latter functions can be calculated numerically and are given by the derivative with respect to  $\delta$  of the
- 420 functions defined in (37) and (38), performed by
- 421 considering the maximization condition (33).
- 422 4.2 Upper bounds to the pull-in parameters
- 423 By using  $(9)_2$  and the lower bound to the CNT
- 424 deflection (26) it follows that  $f(u) \ge f(u_L)$ , then from
- 425 (16) one has

$$\delta \ge G(\delta, \beta) + \frac{\beta}{3}q(\delta), \tag{42}$$

427 where the function

$$G(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) f(u_{L}(x)) dt$$
 (43)

can be calculated numerically.

Inequality (42) implicitly defines an upper bound to the relation between the parameters  $\beta$  and  $\delta$ . The maximum value of the parameters  $\beta$  and the corresponding tip deflection  $\delta$  obtained from this relation by using the stationary condition (33) then provides the upper bounds of the pull-in parameters  $\beta_U$  and  $\delta_U$ , such that  $\beta_{PI} \leq \beta_U$  and  $\delta_{PI} \leq \delta_U$ . Therefore, the upper bounds follow from the two conditions

$$G(\delta_U, \beta_U) + \frac{\beta_U}{3} q(\delta_U) = \delta_U,$$
  

$$\Gamma(\delta_U, \beta_U) + \frac{\beta_U}{3} q'(\delta_U) = 1,$$
(44)

where the function 439

$$\Gamma(\delta, \beta) = \frac{1}{6} \int_{0}^{1} t^{2} (3 - t) a_{1}(t) f'(u_{L}(x)) dt, \tag{45}$$

can be calculated numerically and is given by the derivative with respect to  $\delta$  of the function  $G(\delta, \beta)$  defined in (43), performed by considering the maximization condition (33) and the definition (26) of  $u_I$ .

4.3 Ke et al. estimates to the pull-in voltage 445

The following approximated relation for the pull-in voltage of a CNT whose radius R is much smaller than the gap spacing H between the CNT and ground plane, namely for  $k \gg 1$  has been proposed in [14] 449

$$V_{\rm PI} = 0.85 \sqrt{\frac{1 + K^{FK}}{1 + K^{TIP}}} \frac{H}{L^2} \ln\left(2\frac{H}{R}\right) \sqrt{\frac{EI}{\epsilon_0}},\tag{46}$$

where the parameters 451

$$K^{FK} = \frac{8H^2}{9L^2} = \frac{8}{9}k^2\rho^2,$$

$$K^{TIP} = 2.55 \frac{R^{1/3}(H+R)^{2/3}}{L} = 2.55 \rho(k+1)^{2/3},$$
(47)

take into account for the effects of finite kinematics and concentrated-tip charge, respectively. Considering the definition (4)<sub>1</sub> of the normalized pull-in voltage, from (46) and (47) it follows 453

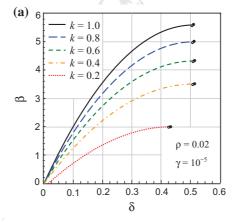
**Table 1** Lower and upper bounds of the pull-in parameters for a CNT switch with k = 1.0, for various values of the van der Waals parameter  $\gamma$  and geometric ratio  $\rho$ 

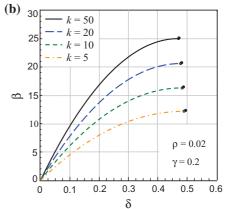
k = 1	$\rho = 0.01$				ρ = 0.05				ρ = 0.1			
γ	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$
0	0.5119	5.8346	0.5193	5.9082	0.4884	4.8695	0.4923	4.9062	0.4700	4.0432	0.4722	4.0619
0.1	0.4017	4.2413	0.4088	4.3134	0.3942	3.6010	0.3996	3.6477	0.3874	3.0298	0.3917	3.0601
0.2	0.3477	3.0363	0.3550	3.1098	0.3437	2.5965	0.3500	2.6497	0.3401	2.1983	0.3455	2.2368
0.3	0.3091	1.9975	0.3167	2.0724	0.3070	1.7162	0.3139	1.7744	0.3050	1.4591	0.3113	1.5043
0.4	0.2785	1.0613	0.2862	1.1374	0.2775	0.9150	0.2848	0.9774	0.2766	0.7805	0.2836	0.8313
0.5	0.2527	0.1975	0.2606	0.2744	0.2526	0.1708	0.2603	0.2365	0.2524	0.1460	0.2600	0.2016

**Table 2** Lower and upper bounds of the pull-in parameters for a CNT switch with k = 10, for various values of the van der Waals parameter  $\gamma$  and geometric ratio  $\rho$ 

k = 10	ρ = 0.01	l			ρ = 0.05	5		<b>5</b> / 7/	ρ = 0.1			
γ	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$	$\delta_L$	$\beta_L$	$\delta_U$	$\beta_U$
0	0.4978	18.515	0.5029	18.687	0.4565	11.939	0.4578	11.975	0.4363	8.2986	0.4368	8.3090
$2 \times 10^4$	0.4176	14.924	0.4235	15.114	0.3985	9.8578	0.4015	9.9198	0.3876	6.9270	0.3895	6.9538
$4 \times 10^4$	0.3725	12.060	0.3789	12.263	0.3607	8.0684	0.3648	8.1521	0.3537	5.7083	0.3567	5.7512
$6 \times 10^4$	0.3394	9.5547	0.3461	9.7693	0.3316	6.4495	0.3365	6.5520	0.3269	4.5860	0.3309	4.6443
$8 \times 10^4$	0.3127	7.2818	0.3197	7.5054	0.3075	4.9490	0.3132	5.0683	0.3043	3.5334	0.3092	3.6063
$10 \times 10^4$	0.2901	5.1768	0.2973	5.4081	0.2868	3.5381	0.2930	3.6725	0.2847	2.5347	0.2904	2.6215

Fig. 2 Relations between electrostatic loading parameter  $\beta$  and tip deflection  $\delta$  obtained from the shooting method, for various geometric ratios k and two different values of  $\gamma$ . Lower and upper estimates of the pull-in parameters are denoted by small circles and small points, respectively





$$\beta_{Ke} = \frac{\pi \epsilon_0 V_{Pl}^2 L^4}{EI H^2} = \pi 0.85^2 \frac{1 + K^{FK}}{1 + K^{TIP}} \ln^2 \left( 2 \frac{H}{R} \right)$$
$$= \pi 0.85^2 \frac{(1 + 8 k^2 \rho^2 / 9) \ln^2 (2k)}{1 + 2.55 \rho (k + 1)^{2/3}}.$$
 (48)

### 5 Results

Lower and upper estimates for the normalized pull-in voltage  $\beta_L$  and  $\beta_U$  and the corresponding estimates of the normalized pull-in deflection  $\delta_U$  and  $\delta_L$  have been reported in Tables 1 and 2. In these tables, two different values of the geometric ratio k are considered

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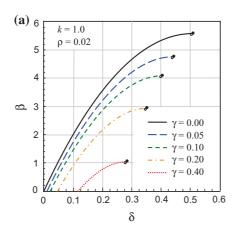
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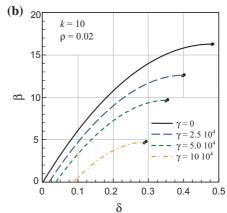
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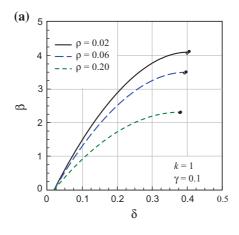
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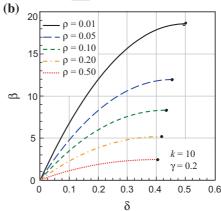




**Fig. 3** Relations between electrostatic loading parameter  $\beta$  and tip deflection  $\delta$  obtained from the shooting method, for the geometric ratios k=1 (a) and k=10 (b) and various values of

the van der Waals parameter  $\gamma$ . Lower and upper estimates of the pull-in parameters are denoted by small circles and small points, respectively





**Fig. 4** Relations between electrostatic loading parameter  $\beta$  and tip deflection  $\delta$  obtained from the shooting method, for k=1 and  $\gamma=0.1$  (a) and k=10 and  $\gamma=0.2$  (b), for various

geometric ratios  $\rho$ . Lower and upper estimates of the pull-in parameters are denoted by small circles and small points, respectively

and results are listed for three specific values of the ratio  $\rho = R/L$ , which denotes the inverse of the CNT slenderness, and for some specific set of the normalized van der Waals parameter  $\gamma$  defined in Eq. (4)<sub>2</sub>.

In order to validate the analytical estimates provided here, the solution to the nonlinear BVP defined by Eqs. (1) and (5) has been calculated by using the numerical integration scheme available in *Mathematica*<sup>®</sup>, which is based on the shooting method. Figures 2, 3, and 4 show the relationships between the electrostatic loading parameter  $\beta$  and tip deflection of the CNT,  $\delta = u(1)$ , obtained by using the function DSolve of *Mathematica*<sup>®</sup>, varying the geometric and material parameters of the CNT switch. In these

figures, the lower and upper analytical estimates of the pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  calculated by using the accurate method described in Sects. 4.1 and 4.2 are marked with small circles and points, respectively. In particular, the curves in Fig. 2 display the variation of normalized CNT tip deflection  $\delta$  with the electrostatic loading parameter  $\beta$  obtained from the shooting method, for various values of the geometric ratio k. A slender CNT ( $\rho = 0.02$ ) subject to weak intermolecular surface forces ( $\gamma = 10^{-5} \div 0.2$ ) is considered therein. These results confirm that the lower and upper analytical bounds for  $\beta$  and  $\delta$  are very close each other (for all the values of the parameter k considered here), thus ensuring extremely accurate estimates of



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the exact pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$ , which correspond to the maximum of the curves  $\beta$  versus  $\delta$  obtained by the numerical integration procedure. As expected, the pull-in voltage  $\beta_{PI}$  is found to increase with the gap spacing H between the electrodes, which is proportional to the parameter k. The pull-in tip displacement  $\delta_{PI}$  displays a non monotonic behavior as k is increased. Indeed, it grows for small values of k and then it decreases as k becomes larger. The contribution of the charge concentrated at the CNT free end has been neglected in most investigations, which thus overestimate the pull-in voltage. Actually, the pull-in voltage is significantly reduced when the contribution of the concentrated load acting at the free end is taken into account.

Figure 3 is similar to Fig. 2 except that it focuses on the effects of the van der Waals attractions on the pullin parameters. The same geometric ratio  $\rho = 0.02$ considered in Fig. 2 has been assumed here. As the beam deflection increases and the normalized gap spacing 1-u decreases, the van der Waals interaction becomes stronger than the electrostatic force. Their magnitude indeed varies with the gap spacing according to the different laws introduced in (3). If the magnitude γ of the van der Waals interaction increases, then it becomes effective at larger gap spacing and, thus, both the pull-in voltage and the pullin tip deflection are found to decrease, as it can be observed in Fig. 3a, b. These plots also confirm that the analytical lower and upper bounds for  $\beta$  and  $\delta$  are very close each other and, thus, also to the exact pullin parameters  $\beta_{PI}$  and  $\delta_{PI}$ , which should lay in between.

The effects of the geometric ratio  $\rho$  on the pull-in parameters can be observed in Fig. 4 for two sets of values of  $\gamma$  and k. As  $\rho$  decreases, namely for slender CNT, the normalized pull-in voltage  $\beta_{PI}$  increases together with the corresponding normalized tip deflection  $\delta_{PI}$ . Note the effects of the CNT slenderness ratio  $\rho$  are more evident for large gap spacing, namely for  $k \gg 1$  (Fig. 4b).

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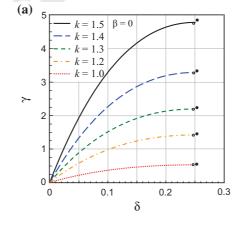
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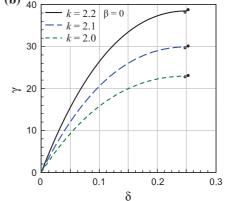
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The variations of the van der Waals parameters γ with the tip displacement  $\delta$  for a freestanding CNT cantilever ( $\beta = 0$ ) obtained by numerical integration are plotted in Fig. 5 for various values of the geometric ratio k. If the parameter  $\gamma$  exceeds its critical value  $\gamma_{PI}$ , which is given by the maximum of the  $\gamma$ - $\delta$  curve obtained by numerical integration, then pull-in instability occurs even if no electric voltage is applied to the electrodes. It can be observed that the estimated values of  $\gamma_{PI}$  and the corresponding pull-in deflection  $\delta_{PI}$  agree very well with the results of the numerical procedure. These plots also show that the critical values of van der Waals parameter is increased by increasing the geometric ratio k. No significant influence of k has been observed on the normalized pull-in tip deflection  $\delta_{PI}$ , which turns out to be about constant and equal to 0.25, independently of k. Lower and upper estimates of critical van der Waals parameter  $\gamma_{PI}$  and tip deflection  $\delta_{PI}$  for a freestanding CNT can be found in Table 3 for some values of the geometric ratio k. There, it can be noted that a stronger van der Waals force is required to induce the pull-in instability as the normalized gap spacing k increases, whereas the normalized pull-in tip deflection  $\delta$  is almost independent of k. Note that the geometric ratio  $\rho$  has no effect on the pull-in value  $\gamma_{PI}$  of the van der

Fig. 5 Relations between van der Waals parameter  $\gamma$  and tip deflection  $\delta$  obtained from the shooting method, for a freestanding nanotube ( $\beta=0$ ) and for small ( $\mathbf{a}$ ) and large ( $\mathbf{b}$ ) values of the geometric ratio k. Lower and upper estimates of the pullin parameters are denoted by small circles and small points, respectively



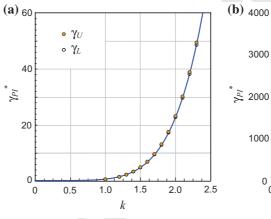




**Table 3** Lower and upper bounds for the parameters  $\gamma$  and  $\delta$  causing the pull-in instability in the absence of electrostatic actuation ( $\beta = 0$ ) and approximated value  $\gamma_{PI}^*$  provided by Eq. (49), for various values of the geometric ratio k

k	$\gamma_{PI}^*$	$\gamma_L$	$\delta_L$	$\gamma_U$	$\delta_U$
0.2	$7.16 \times 10^{-5}$	$7.72 \times 10^{-5}$	0.2456	$7.86 \times 10^{-5}$	0.2513
0.4	$3.24 \times 10^{-3}$	$3.47 \times 10^{-3}$	0.2459	$3.53 \times 10^{-3}$	0.2517
0.6	$3.01 \times 10^{-2}$	$3.21 \times 10^{-2}$	0.2463	$3.26 \times 10^{-2}$	0.2521
0.8	$1.47 \times 10^{-1}$	$1.55 \times 10^{-1}$	0.2467	$1.58 \times 10^{-1}$	0.2525
1	$5.00 \times 10^{-1}$	$5.24 \times 10^{-1}$	0.2471	$5.33 \times 10^{-1}$	0.2529
2	$2.26 \times 10^{1}$	$2.28 \times 10^{1}$	0.2485	$2.32 \times 10^{1}$	0.2543
3	$2.10 \times 10^{2}$	$2.06 \times 10^{2}$	0.2485	$2.09 \times 10^{2}$	0.2543
4	$1.02 \times 10^{3}$	$9.83 \times 10^{2}$	0.2477	$1.00 \times 10^{3}$	0.2535
5	$3.49 \times 10^{3}$	$3.32 \times 10^{3}$	0.2465	$3.38 \times 10^{3}$	0.2523
10	$1.58 \times 10^{5}$	$1.55 \times 10^{5}$	0.2406	$1.58 \times 10^{5}$	0.2463
20	$7.15 \times 10^{6}$	$7.99 \times 10^{6}$	0.2345	$8.14 \times 10^{6}$	0.2401
50	$1.10 \times 10^9$	$1.67 \times 10^{9}$	0.2294	$1.70 \times 10^{9}$	0.2348

Fig. 6 Variation of the van der Waals parameter  $\gamma_{PI}^*$  with the geometric ratio k. The upper and lover values of  $\gamma$  causing the pullin instability for a freestanding CNT cantilever are marked by full and empty circles, respectively



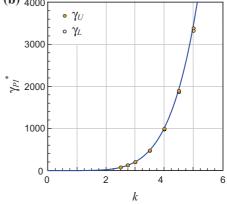
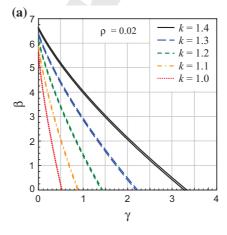
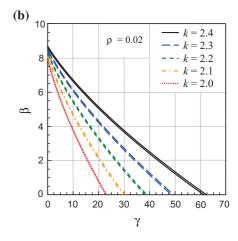


Fig. 7 Normalized variations of the pull-in voltage  $\beta$  with the van der Waals parameter  $\gamma$ , for small (a) and large (b) values of the geometric ratios k





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560 Waals parameter. Indeed, according to Eq. (6)  $\rho$  561 affects the concentrated tip load only, which is 562 vanishing for  $\beta = 0$ .

On the basis of the performed investigations a simple closed-form relation is proposed here for the

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565 pull-in value of the van der Waals parameter for a 566 freestanding CNT cantilever, namely

$$\gamma_{PI}^* = \frac{1}{2}k^{11/2}. (49)$$

The variations of  $\gamma_{PI}^*$  with k are plotted in Fig. 6a, b together with the upper and lower bounds  $\gamma_U$  and  $\gamma_L$  provided by the present analysis. Values of  $\gamma_{PI}^*$  for some specific value of k have been reported in Table 3 also. In Fig. 6a, it can be noted that relation (49) fits very well the lower bounds  $\gamma_U$  for small values of k, namely for k < 2.8, and thus it can be conveniently used for the safe design of CNT switches with a small gap spacing. Equation (49) provides accurate predictions also for k > 2.8, as it can be observed in Fig. 6b, but in this case  $\gamma_{PI}^*$  may result a bit larger than  $\gamma_U$ , as it can be noted in Table 3 for  $k = 3 \div 5$ . Relation (49) actually defines a minimum gap spacing  $H_{min}$  or,

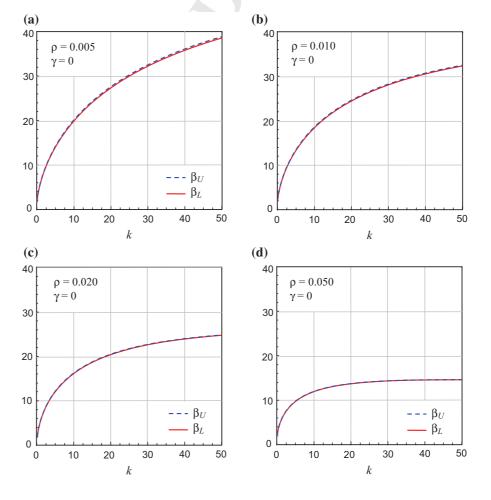
equivalently, a maximum CNT length  $L_{max}$  for preventing the pull-in collapse of a CNT in the absence of electrostatic loading, namely

$$H_{min} = \left(C_6 \sigma^2 \frac{\pi^2 L^4}{EI}\right)^{2/11} R^{1/11},$$

$$L_{max} = \left(\frac{EI}{C_6 \sigma^2 \pi^2}\right)^{1/4} \left(\frac{H^{11}}{R}\right)^{1/8}.$$
(50)

The variations of  $\beta_U$  and  $\beta_L$  with  $\gamma$  are plotted in Fig. 7 for various value of the geometric ratio k. These estimates are very close each other and, thus, extremely accurate, for every value of the van der Waals parameter. Both the pull-in voltage  $\beta$  and the limit value of the coefficients  $\gamma$  increase as the parameter k is increased. In general, for assigned geometry, namely for given values of  $\rho$  and k, the pull-in voltage decreases as the strength of the van der Waals attractions increases. The pull-in voltage

**Fig. 8** Variations of lower and upper bounds  $β_L$  and  $β_U$  of the pull-in voltage with the geometric ratio k, for γ = 0 and for various geometric ratios ρ







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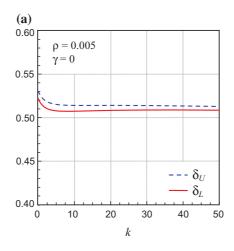
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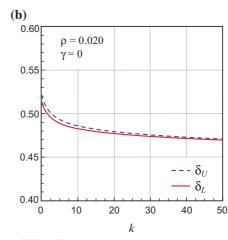
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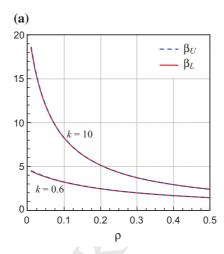
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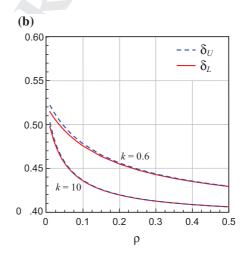
**Fig. 9** Variations of  $\delta_L$  and  $\delta_U$  with the geometric ratio k, for  $\gamma = 0$  and for two different geometric ratios  $\rho$ 





**Fig. 10** Variations of  $\beta_L$  and  $\beta_U$  (**a**), and  $\delta_L$  and  $\delta_U$  (**b**) with the geometric ratio  $\rho$  for two different values of the geometric ratio k and  $\gamma = 0$ 





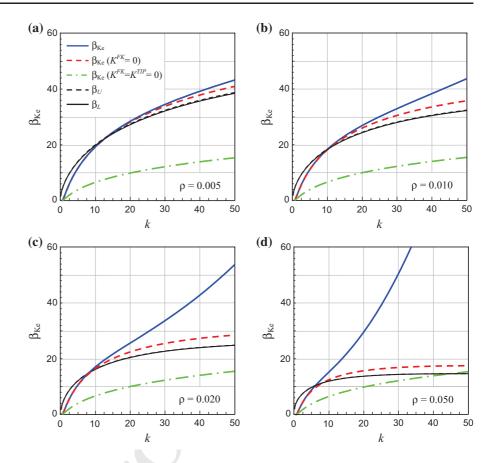
vanishes when the van der Waals parameter attains its critical values  $\gamma_{PI}$ . Negative values of  $\beta$  then imply that a repulsive electrostatic force is required to prevent pull-in instability induced by the van der Waals attraction when it overcomes the elastic restoring force. In this case, the CNT collapses onto and adheres to the ground plane in the absence of electrostatic actuation, due only to the van der Waals attraction that is responsible of the occurring of stiction [31]. This phenomenon is exploited in non-volatile memory cells, where the switch is hold in the closed state with no need of continued power input. The occurrence of stiction in applications such as nanoactuators, nanoresonators and nano-tweezers may instead limit the range of operability of the device and lead to undesirable consequences.

The variations of lower and upper bounds of the pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  with the geometric ratio

k are plotted in Figs. 8 and 9, respectively, for vanishing contribution of the van der Waals force  $(\gamma = 0)$ . The lower and upper analytical bounds turn out to be very close each other for every value of the geometric ratio k, thus ensuring accurate estimates of the pull-in parameters. Moreover, the pull-in voltage is found to increase with the gap spacing parameter k, as expected, and it seems to approach an almost constant limit values for large k. Note that the pull-in deflection  $\delta_{PI}$  display a limited variation with k so that the range of variation of the plots in Fig. 9 has been restricted between 0.4 and 0.6 to make the gap more visible. Due to the adopted graphical representation, it may seem that the predicted upper and lower pull-in deflections  $\delta_L$  and  $\delta_U$  in Fig. 9 are more separated than the upper and lower pull-in voltages plotted in Fig. 8, but actually the former are as close as the latter.



Fig. 11 Variation of approximated normalized pull-in voltage  $\beta_{Ke}$  with k for four values of slenderness ratio ρ: considering both effects of concentrated charge and finite kinematics (solid line), considering only the effect of concentrated charge (dashed line), neglecting both effects (dash-dotted line). The analytical predictions of the lower and upper bounds are plotted by solid and dashed black lines, respectively



The variations of lower and upper bounds of the pull-in parameters  $\beta_{PI}$  and  $\delta_{PI}$  with the geometric ratio  $\rho$  are plotted in Fig. 10a, b, respectively, neglecting the contribution of the van der Waals attractions ( $\gamma = 0$ ). It can be observed that increasing the geometric ratio  $\rho$  results in decreasing the pull-in voltage (Fig. 10a) and the normalized pull-in displacement (Fig. 10b). The rapid variation observed for k = 10, namely for large gap spacing, proves that the pull-in parameters are very sensitive to the geometric ratio  $\rho$ , especially when it is small, namely for very slender CNTs. Note the reduced range of variation considered for  $\delta_L$  and  $\delta_U$  in Fig. 10b.

According to Eq. (48), the variations of the approximated pull-in voltage  $\beta_{Ke}$  proposed by Ke et al. [14] with k are plotted in Fig. 11 for four values of  $\rho$ . In particular, the blue solid lines take into consideration both the effects of concentrated charge and finite kinematics, the red dashed lines take into consideration the effect of concentrated charge only, and the green dash-dotted lines neglect both effects. The

analytical predictions of the lower and upper bounds proposed here are plotted in the same figures by solid and dashed black lines, respectively. From Fig. 11 it can be observed that the effect of finite kinematics, namely the term  $K^{FK}$ , is negligible for k < 20 if  $\rho = 0.005$ , for k < 15 if  $\rho = 0.01$ , for k < 10 if  $\rho = 0.02$ , and for k < 5 if  $\rho = 0.05$ , whereas the effect of concentrated charge  $K^{TIP}$  can never be neglected. Moreover, if the effects of finite kinematics are neglected, relation (48) roughly approximates the estimates of the pull-in voltage obtained by the present approach. However, Eq. (48) provides estimates of the pull-in voltage smaller than the lower bound  $\beta_L$  for small values of k and larger than the upper bound  $\beta_U$  for large values of k.

#### 6 Conclusions

Analytical lower and upper bounds for the pull-in voltage and deflection of an electro-statically actuated

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CNT cantilever switch are proposed and then validated by comparison with the results obtained from a numerical integration procedure of the governing nonlinear BVP. The combined effects of tip charge concentration and van der Waals attractions are found to reduce the pull-in voltage considerably. The upper and lower bounds are very close to the exact values, for every set of material and loading parameter considered here, thus proving the efficiency of the proposed approach. Moreover, they are found to improve the accuracy with respect to approximated relations proposed in the literature for the fast estimate of the pull-in voltage of CNT switches.

In conclusion, the present study can be regarded as a useful tools for the safe design of NEMS devices exploiting the smart properties of CNTs. It allows indeed for preventing unpredicted structural damage during operation, thus assuring robust and consistent performance over many actuation cycles.

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- 691 Compliance with ethical standards
- 692 **Conflict of interest** The authors declare that they have no conflict of interest.

#### 694 Appendix

- 695 The proofs of the two lemmas used in Sect. 3 for 696 obtaining the upper and lower bounds to the CNT 697 deflection are given in the following. These proofs 698 were also given in [16, 17] and are reported here for 699 the sake of convenience.
- 700 **Lemma A** Let the function h(x) be continuous up to 701 the third derivative for  $x \in [0, 1]$  and satisfy the 702 following conditions

$$h(0) = 0, \quad h(1) = 0, \quad h'(0) = 0, \quad h''(1) = 0,$$
  
 $h'''(1) = 0,$ 

(51)

704 and

$$h^{V}(x) \le 0$$
, for  $x \in [0, 1]$  (52)

706 then

$$h(x) \ge 0$$
, for  $x \in [0, 1]$  (53)

*Proof* By using the mean value theorem, from continuity and conditions  $(51)_{1,2}$  it follows that there exists  $x_1 \in [0, 1]$  such that  $h'(x_1) = 0$ . Then, by using conditions  $(51)_{3,4}$  there exist  $x_2 \in [0, x_1]$  and  $x_3 \in [x_2, 1]$  such that  $h''(x_2) = 0$  and  $h'''(x_3) = 0$ . Since the function h'''(x) is concave for  $x \in [0, 1]$  according to (52), it follows that  $h''(x) \le 0$  for  $x \in [x_2, 1]$  and  $h''(x) \ge 0$  for  $x \in [0, x_1]$  and  $h'(x) \ge 0$  for  $x \in [0, x_1]$  and  $h'(x) \le 0$  for  $x \in [x_1, 1]$ . Since h(0) = h(1) = 0 according to Eq.  $(51)_{1,2}$ , then it necessarily follows that  $h(x) \ge 0$  for  $x \in [0, 1]$ , so that condition (53) holds true. □

**Lemma B** Let the function g(x) be continuous up to the third derivative for  $x \in [0, 1]$  and satisfy the following conditions

$$g(0) = 0$$
,  $g(1) = 0$ ,  $g'(0) = 0$ ,  $g''(1) = 0$ . (54)

$$g^{IV}(x) \ge 0$$
, for  $x \in [0, 1]$  (55)

$$g(x) \ge 0$$
, for  $x \in [0, 1]$  (56)

*Proof* By using the mean value theorem, from conditions  $(54)_{1,2}$  it follows that there exists  $x_1 \in [0, 1]$  such that  $g'(x_1) = 0$ . Moreover, by using conditions  $(54)_{3,4}$  there exists  $x_2 \in [0, x_1]$  such that  $g''(x_2) = 0$ . Condition (55) then implies that g''(x) is convex. It follows that  $g''(x) \le 0$  for  $x \in [x_2, 1]$  and  $g''(x) \ge 0$  for  $x \in [0, x_2]$ , and thus  $g'(x) \ge 0$  for  $x \in [0, x_1]$  and  $g'(x) \le 0$  for  $x \in [x_1, 1]$ . Since g(0) = g(1) = 0 according to conditions  $(54)_{1,2}$ , then it necessarily follows that inequality (56) holds true. □

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